





**SN74HCS137** JAJSPU6A – SEPTEMBER 2020 – REVISED JUNE 2021

# SN74HCS137 3 - 8 ライン・デコーダ / デマルチプレクサ、アドレス・ラッチお よびシュミット・トリガ入力付き

# 1 特長

- 広い動作電圧範囲:2V~6V
- シュミット・トリガ入力により低速の入力信号またはノイ ズの多い入力信号に対応
- 低い消費電力
  - I<sub>CC</sub>: 100nA (標準値)
  - 入力リーク電流:±100nA (標準値)
- 6V で±7.8mA の出力駆動能力
- 拡張周囲温度範囲:-40°C~+125°C、T<sub>△</sub>

# 2 アプリケーション

- データ・バスを共有するメモリ・デバイスの選択
- チップ・セレクト・アプリケーションの出力の必要数の低
- データの転送

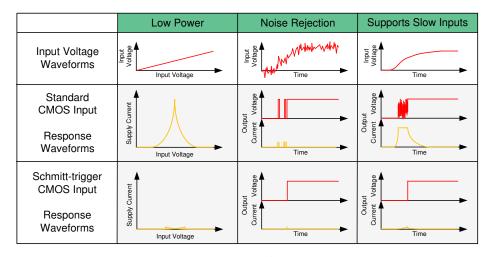
# 3 概要

SN74HCS137 は、ラッチ・アドレス入力、1 つの通常の出 カストローブ (G<sub>n</sub>)、および 1 つのアクティブ LOW 出力ス トローブ ( $\overline{G}_{1}$ ) を備えた 3-8 デコーダです。 ラッチ・イネ ーブル (LE) 入力が LOW の場合、このデバイスは標準の 3-8 デコーダとして動作します。 ラッチ・イネーブル (LE) 入力が HIGH の場合、アドレス・ラッチは以前の状態を維 持します。いずれかのストローブ入力により出力が無効化 されると、すべての出力は HIGH 状態に強制されます。 い ずれかまたは両方のストローブ入力により出力が無効化さ れている場合以外は、選択された出力のみが LOW であ り、その他のすべての出力は HIGH です。

#### デバイス情報

| 部品番号         | パッケージ <sup>(1)</sup> | 本体サイズ (公称)      |
|--------------|----------------------|-----------------|
| SN74HCS137PW | TSSOP (16)           | 5.00mm × 4.40mm |
| SN74HCS137D  | SOIC (16)            | 9.90mm × 3.90mm |

利用可能なすべてのパッケージについては、このデータシートの 末尾にある注文情報を参照してください。



シュミット・トリガ入力の利点



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# 4 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

# Changes from Revision \* (September 2020) to Revision A (May 2021)

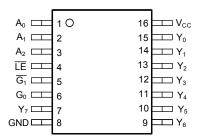
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# **5 Pin Configuration and Functions**



# D or PW Package 16-Pin SOIC or TSSOP Top View

表 5-1. Pin Functions

| PIN                  | N               |     | 2 0 1.1 m r unotions       |
|----------------------|-----------------|-----|----------------------------|
| SOIC or TSSOP<br>NO. | NAME            | I/O | DESCRIPTION                |
| 1                    | A <sub>0</sub>  | I   | Address select 0           |
| 2                    | A <sub>1</sub>  | 1   | Address select 1           |
| 3                    | A <sub>2</sub>  | I   | Address select 2           |
| 4                    | ΙĒ              | I   | Latch enable, active low   |
| 5                    | G <sub>1</sub>  | I   | Strobe input 1, active low |
| 6                    | G <sub>0</sub>  | I   | Strobe input 0             |
| 7                    | Y <sub>7</sub>  | 0   | Output 7                   |
| 8                    | GND             | _   | Ground                     |
| 9                    | Y <sub>6</sub>  | 0   | Output 6                   |
| 10                   | Y <sub>5</sub>  | 0   | Output 5                   |
| 11                   | Y <sub>4</sub>  | 0   | Output 4                   |
| 12                   | Y <sub>3</sub>  | 0   | Output 3                   |
| 13                   | Y <sub>2</sub>  | 0   | Output 2                   |
| 14                   | Y <sub>1</sub>  | 0   | Output 1                   |
| 15                   | Υ <sub>0</sub>  | 0   | Output 0                   |
| 16                   | V <sub>CC</sub> | _   | Positive supply            |



# **6 Specifications**

# **6.1 Absolute Maximum Ratings**

over operating free-air temperature range (unless otherwise noted)(1)

|                  |  |   | MIN  | MAX | UNIT |
|------------------|--|---|------|-----|------|
| V <sub>CC</sub>  | Supply voltage                                   |   | -0.5 | 7   | V    |
| I <sub>IK</sub>  | Input clamp current <sup>(2)</sup>               | $V_{I} < -0.5 \text{ V or } V_{I} > V_{CC} + 0.5 \text{ V}$ |      | ±20 | mA   |
| I <sub>OK</sub>  | Output clamp current <sup>(2)</sup>              | $V_{I} < -0.5 \text{ V or } V_{I} > V_{CC} + 0.5 \text{ V}$ |      | ±20 | mA   |
| Io               | Continuous output current                        | Continuous output current $V_O = 0$ to $V_{CC}$             |      | ±35 | mA   |
|                  | Continuous current through V <sub>CC</sub> or GN | D   |      | ±70 | mA   |
| TJ               | Junction temperature <sup>(3)</sup>              |   |      | 150 | °C   |
| T <sub>stg</sub> | Storage temperature                              |   | -65  | 150 | °C   |

- (1) Stresses beyond those listed under Absolute Maximum Rating may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Condition. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
- (3) Guaranteed by design.

#### 6.2 ESD Ratings

|                    |                         |  | VALUE | UNIT |
|--------------------|-------------------------|--|-------|------|
| V                  | Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/<br>JEDEC JS-001 <sup>(1)</sup>          | ±4000 | V    |
| V <sub>(ESD)</sub> |                         | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> | ±1500 | V    |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

# **6.3 Recommended Operating Conditions**

over operating free-air temperature range (unless otherwise noted)

|                 |                     | MIN | NOM | MAX             | UNIT |
|-----------------|---------------------|-----|-----|-----------------|------|
| V <sub>CC</sub> | Supply voltage      | 2   | 5   | 6               | V    |
| VI              | Input voltage       | 0   |     | V <sub>CC</sub> | V    |
| Vo              | Output voltage      | 0   |     | V <sub>CC</sub> | V    |
| T <sub>A</sub>  | Ambient temperature | -40 |     | 125             | °C   |

#### 6.4 Thermal Information

|                       |  | SN74F      |          |      |
|-----------------------|--|------------|----------|------|
|                       | THERMAL METRIC <sup>(1)</sup>                | PW (TSSOP) | D (SOIC) | UNIT |
|                       |  | 16 PINS    | 16 PINS  |      |
| R <sub>0JA</sub>      | Junction-to-ambient thermal resistance       | 141.2      | 122.2    | °C/W |
| R <sub>0JC(top)</sub> | Junction-to-case (top) thermal resistance    | 78.8       | 80.9     | °C/W |
| $R_{\theta JB}$       | Junction-to-board thermal resistance         | 85.8       | 80.6     | °C/W |
| $\Psi_{JT}$           | Junction-to-top characterization parameter   | 27.7       | 40.4     | °C/W |
| $\Psi_{JB}$           | Junction-to-board characterization parameter | 85.5       | 80.3     | °C/W |
| R <sub>0JC(bot)</sub> | Junction-to-case (bottom) thermal resistance | N/A        | N/A      | °C/W |

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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# **6.5 Electrical Characteristics**

over operating free-air temperature range; typical values measured at  $T_A$  = 25°C (unless otherwise noted).

|                 | PARAMETER  | TEST CO                    | NDITIONS                       | V <sub>cc</sub> | MIN | TYP                      | MAX        | UNIT                  |                         |  |  |
|-----------------|--|----------------------------|--------------------------------|-----------------|-----|--------------------------|------------|-----------------------|-------------------------|--|--|
|                 |  |                            |                                | 2 V             | 0.7 |                          | 1.5        |                       |                         |  |  |
| V <sub>T+</sub> | Positive switching threshold                                   |                            |                                | 4.5 V           | 1.7 |                          | 3.15       | V                     |                         |  |  |
|                 |  |                            |                                | 6 V             | 2.1 |                          | 4.2        |                       |                         |  |  |
|                 |  |                            |                                | 2 V             | 0.3 |                          | 1.0        |                       |                         |  |  |
| V <sub>T-</sub> | Negative switching threshold                                   |                            |                                | 4.5 V           | 0.9 |                          | 2.2        | V                     |                         |  |  |
|                 |  |                            |                                | 6 V             | 1.2 |                          | 3.0        |                       |                         |  |  |
|                 |  |                            |                                | 2 V             | 0.2 |                          | 1.0        |                       |                         |  |  |
| $\Delta V_T$    | Hysteresis (V <sub>T+</sub> - V <sub>T-</sub> ) <sup>(1)</sup> |                            |                                | 4.5 V           | 0.4 |                          | 1.4        | V                     |                         |  |  |
|                 |  |                            |                                | 6 V             | 0.6 |                          | 1.6        |                       |                         |  |  |
|                 |  |                            |                                |                 |     | I <sub>OH</sub> = -20 μA | 2 V to 6 V | V <sub>CC</sub> - 0.1 | V <sub>CC</sub> - 0.002 |  |  |
| V <sub>OH</sub> | High-level output voltage                                      | $V_I = V_{IH}$ or $V_{IL}$ | I <sub>OH</sub> = -6 mA        | 4.5 V           | 4.0 | 4.3                      |            | V                     |                         |  |  |
|                 |  |                            | I <sub>OH</sub> = -7.8 mA      | 6 V             | 5.4 | 5.75                     |            |                       |                         |  |  |
|                 |  |                            | I <sub>OL</sub> = 20 μA        | 2 V to 6 V      |     | 0.002                    | 0.1        |                       |                         |  |  |
| V <sub>OL</sub> | Low-level output voltage                                       | $V_I = V_{IH}$ or $V_{IL}$ | I <sub>OL</sub> = 6 mA         | 4.5 V           |     | 0.18                     | 0.30       | V                     |                         |  |  |
|                 |  |                            | I <sub>OL</sub> = 7.8 mA       | 6 V             |     | 0.22                     | 0.33       |                       |                         |  |  |
| I <sub>I</sub>  | Input leakage current  | $V_I = V_{CC}$ or 0        |                                | 6 V             |     | ±100                     | ±1000      | nA                    |                         |  |  |
| I <sub>CC</sub> | Supply current   | $V_I = V_{CC}$ or 0, $I_C$ | $V_I = V_{CC}$ or 0, $I_O = 0$ |                 |     | 0.1                      | 2          | μA                    |                         |  |  |
| Ci              | Input capacitance  |                            |                                | 2 V to 6 V      |     |                          | 5          | pF                    |                         |  |  |

<sup>(1)</sup> Guaranteed by design.

# **6.6 Timing Characteristics**

 $\underline{C_L}$  = 50 pF; over operating free-air temperature range (unless otherwise noted). See Parameter Measurement Information.

|                 |                |  |                 | Operating | free-air | temperature | (T <sub>A</sub> ) |      |
|-----------------|----------------|--|-----------------|-----------|----------|-------------|-------------------|------|
|                 | PARAMETER      |  | V <sub>cc</sub> | 25°C      |          | -40°C to 1  | 25°C              | UNIT |
|                 |                |  |                 | MIN       | MAX      | MIN         | MAX               |      |
|                 |                | LE pulse width                             | 2 V             | 6         |          | 9           |                   |      |
| t <sub>w</sub>  | Pulse duration |  | 4.5 V           | 5         |          | 7           |                   | ns   |
|                 |                |  | 6 V             | 5         |          | 7           |                   |      |
|                 |                |  | 2 V             | 4         |          | 5           |                   |      |
| t <sub>su</sub> | Setup time     | A <sub>n</sub> to <del>LE</del> setup time | 4.5 V           | 3         |          | 4           |                   | ns   |
|                 |                |  | 6 V             | 3         |          | 4           |                   |      |
|                 |                | $A_n$ to $\overline{LE}$ hold time         | 2 V             | 4         |          | 5           |                   |      |
| t <sub>h</sub>  | Hold time      |  | 4.5 V           | 4         |          | 5           |                   | ns   |
|                 |                |  | 6 V             | 4         |          | 5           |                   |      |



# **6.7 Switching Characteristics**

 $C_L$  = 50 pF; over operating free-air temperature range (unless otherwise noted). See Parameter Measurement Information.

|                 |                   |                |            |                 | Operat | ing fr | ee-air | temperat | ure (T <sub>A</sub> ) |     |      |
|-----------------|-------------------|----------------|------------|-----------------|--------|--------|--------|----------|-----------------------|-----|------|
|                 | PARAMETER         |                | то         | V <sub>cc</sub> | 25°C   |        |        | -40°     | C to 125              | °C  | UNIT |
|                 |                   |                |            |                 | MIN TY | P      | MAX    | MIN      | TYP                   | MAX |      |
|                 | Propagation delay | A <sub>n</sub> | 7          | 2 V             |        | 17     | 35     |          |                       | 51  |      |
|                 |                   |                |            | 4.5 V           |        | 7      | 14     | 20       |                       |     |      |
|                 |                   |                |            | 6 V             |        | 6      | 12     |          |                       | 17  |      |
|                 |                   | G or G         | Y          | 2 V             | 15 30  |        |        | 48       |                       |     |      |
| t <sub>pd</sub> |                   |                |            | 4.5 V           | 7      |        | 11     | 17       |                       |     | ns   |
|                 |                   |                |            | 6 V             |        | 6      | 9      |          |                       | 15  |      |
|                 |                   |                | Y          | 2 V             |        | 18     | 39     |          |                       | 60  |      |
|                 |                   | LE             |            | 4.5 V           |        | 8      | 16     | 24       |                       |     |      |
|                 |                   |                |            |                 | 6 V    |        | 7      | 15       |                       |     | 21   |
|                 |                   |                | Any output | 2 V             |        |        | 9      |          | 16                    |     |      |
| t <sub>t</sub>  | Transition-time   |                |            | 4.5 V           |        |        | 5      |          |                       | 9   | ns   |
|                 |                   |                |            | 6 V             |        |        | 4      |          |                       | 8   |      |

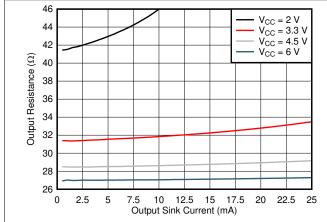
# **6.8 Operating Characteristics**

over operating free-air temperature range; typical values measured at  $T_A$  = 25°C (unless otherwise noted).

|     | PARAMETER                   | TEST CONDITIONS | V <sub>cc</sub> | MIN | TYP | MAX | UNIT |
|-----|-----------------------------|-----------------|-----------------|-----|-----|-----|------|
| Cnd | wer dissipation capacitance | No load         | 2 V to 6 V      |     | 40  |     | pF   |

# **6.9 Typical Characteristics**

 $T_A = 25^{\circ}C$ 



**図 6-1. Output driver resistance in LOW state.** 

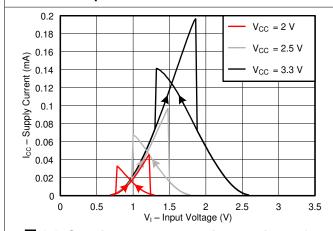


図 6-3. Supply current across input voltage, 2-, 2.5-, and 3.3-V supply

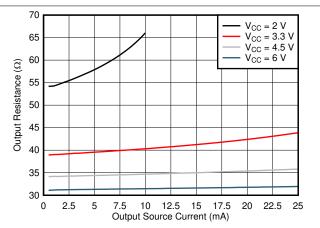


図 6-2. Output driver resistance in HIGH state.

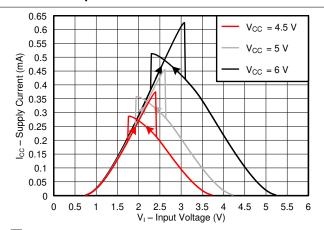


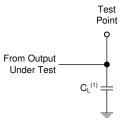
図 6-4. Supply current across input voltage, 4.5-, 5-, and 6-V supply

# 7 Parameter Measurement Information

Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_t$  < 2.5 ns.

For clock inputs,  $f_{\text{max}}$  is measured when the input duty cycle is 50%.

The outputs are measured one at a time with one input transition per measurement.



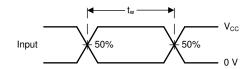


図 7-2. Voltage Waveforms, Pulse Duration

(1)  $C_L$  includes probe and test-fixture capacitance.

# 図 7-1. Load Circuit for Push-Pull Outputs

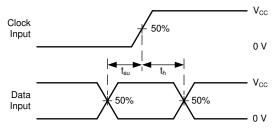
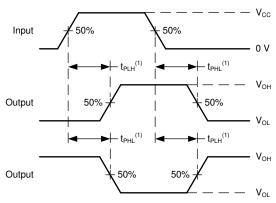
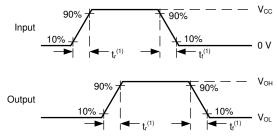


図 7-3. Voltage Waveforms, Setup and Hold Times



(1) The greater between  $t_{PLH}$  and  $t_{PHL}$  is the same as  $t_{pd}$ .

#### 図 7-4. Voltage Waveforms Propagation Delays



(1) The greater between  $t_{r}$  and  $t_{f}$  is the same as  $t_{t}$ .

図 7-5. Voltage Waveforms, Input and Output Transition Times

# 8 Detailed Description

#### 8.1 Overview

The SN74HCS137 is a high speed silicon gate CMOS decoder well suited to memory address decoding or data routing applications. It contains a single 3:8 decoder. All inputs include Schmitt-triggers allowing for slow input transitions and providing additional noise margin.

The SN74HCS137 has three address select inputs ( $A_2$ ,  $A_1$ , and  $A_0$ ). When the latch enable ( $\overline{\text{LE}}$ ) input is low, the circuit functions as a normal one-of-eight decoder. When the latch enable ( $\overline{\text{LE}}$ ) input is high, the address latches will maintain their previous states, regardless of any changes at the address select inputs.

Two strobe inputs ( $\overline{G}_1$  and  $G_0$ ) are provided to simplify cascading and to facilitate demultiplexing. When any input strobe is active, all outputs are forced into the high state.

The demultiplexing function is accomplished by first using the select inputs to choose the desired output, and then using one of the strobe inputs as the data input.

The outputs for the SN74HCS137 are normally high, and low when selected.

### 8.2 Functional Block Diagram

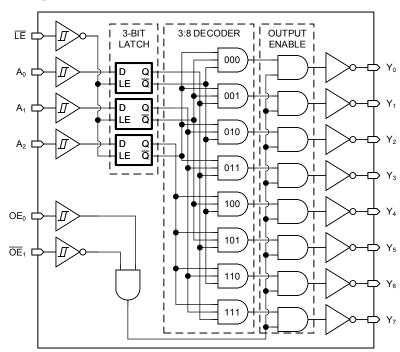


図 8-1. Logic Diagram (Positive Logic) for the SN74HCS137

#### 8.3 Feature Description

#### 8.3.1 Balanced CMOS Push-Pull Outputs

This device includes balanced CMOS push-pull outputs. The term "balanced" indicates that the device can sink and source similar currents. The drive capability of this device may create fast edges into light loads so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to overcurrent. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.

Unused push-pull CMOS outputs should be left disconnected.

#### 8.3.2 CMOS Schmitt-Trigger Inputs

This device includes inputs with the Schmitt-trigger architecture. These inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Electrical Characteristics* table from the input to ground. The worst case resistance is calculated with the maximum input voltage, given in the *Absolute Maximum Ratings* table, and the maximum input leakage current, given in the *Electrical Characteristics* table, using Ohm's law ( $R = V \div I$ ).

The Schmitt-trigger input architecture provides hysteresis as defined by  $\Delta V_T$  in the *Electrical Characteristics* table, which makes this device extremely tolerant to slow or noisy inputs. While the inputs can be driven much slower than standard CMOS inputs, it is still recommended to properly terminate unused inputs. Driving the inputs with slow transitioning signals will increase dynamic current consumption of the device. For additional information regarding Schmitt-trigger inputs, please see Understanding Schmitt Triggers.

### 8.3.3 Clamp Diode Structure

The inputs and outputs to this device have both positive and negative clamping diodes as depicted in Electrical Placement of Clamping Diodes for Each Input and Output.

#### 注意

Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

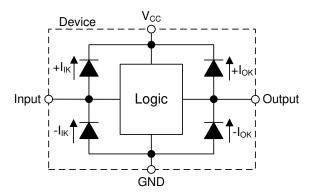


図 8-2. Electrical Placement of Clamping Diodes for Each Input and Output

English Data Sheet: SCLS831

# **8.4 Device Functional Modes**

Function Table lists the functional modes of the SN74HCS137.

表 8-1. Function Table

|    |                | INPU | TS <sup>(1)</sup> |                |                |                |  |                | OUTI           | PUTS           |                |                |                |
|----|----------------|------|-------------------|----------------|----------------|----------------|--|----------------|----------------|----------------|----------------|----------------|----------------|
| LE | G <sub>0</sub> | G₁   | A <sub>2</sub>    | A <sub>1</sub> | A <sub>0</sub> | Y <sub>0</sub> | Y <sub>1</sub>   | Y <sub>2</sub> | Y <sub>3</sub> | Y <sub>4</sub> | Y <sub>5</sub> | Y <sub>6</sub> | Y <sub>7</sub> |
| Х  | Х              | Н    | Х                 | Х              | Х              | Н              | Н  | Н              | Н              | Н              | Н              | Н              | Н              |
| Х  | L              | Х    | Х                 | Х              | Х              | Н              | Н  | Н              | Н              | Н              | Н              | Н              | Н              |
| L  | Н              | L    | L                 | L              | L              | L              | Н  | Н              | Н              | Н              | Н              | Н              | Н              |
| L  | Н              | L    | L                 | L              | Н              | Н              | L  | Н              | Н              | Н              | Н              | Н              | Н              |
| L  | Н              | L    | L                 | Н              | L              | Н              | Н  | L              | Н              | Н              | Н              | Н              | Н              |
| L  | Н              | L    | L                 | Н              | Н              | Н              | Н  | Н              | L              | Н              | Н              | Н              | Н              |
| L  | Н              | L    | Н                 | L              | L              | Н              | Н  | Н              | Н              | L              | Н              | Н              | Н              |
| L  | Н              | L    | Н                 | L              | Н              | Н              | Н  | Н              | Н              | Н              | L              | Н              | Н              |
| L  | Н              | L    | Н                 | Н              | L              | Н              | Н  | Н              | Н              | Н              | Н              | L              | Н              |
| L  | Н              | L    | Н                 | Н              | Н              | Н              | Н  | Н              | Н              | Н              | Н              | Н              | L              |
| Н  | Н              | L    | Х                 | Х              | Х              | Depen          | Depends upon the address previously applied while LE was at a logic low. |                |                |                |                |                |                |

<sup>(1)</sup> H = High Voltage Level, L = Low Voltage Level, X = Don't Care



# 9 Application and Implementation

注

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#### 9.1 Application Information

The SN74HCS137 is used to control multiple devices that operate on a shared data bus. A decoder provides the capability to have a binary encoded input activate only one of the device's outputs. This is ideal for solid state memory applications where multiple devices have to be read or written to with a limited number of GPIO pins used on the system controller. The decoder is used to activate the chip select (CS) input to the selected memory device, and the controller can then read or write from that device alone when using a shared bus.

### 9.2 Typical Application

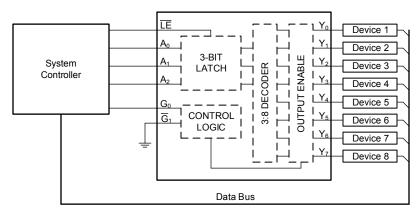


図 9-1. Typical application block diagram

#### 9.2.1 Design Requirements

#### 9.2.1.1 Power Considerations

Ensure the desired supply voltage is within the range specified in the *Recommended Operating Conditions*. The supply voltage sets the device's electrical characteristics as described in the *Electrical Characteristics*.

The positive voltage supply must be capable of sourcing current equal to the total current to be sourced by all outputs of the SN74HCS137 plus the maximum static supply current,  $I_{CC}$ , listed in *Electrical Characteristics* and any transient current required for switching. The logic device can only source as much current as is provided by the positive supply source. Be sure not to exceed the maximum total current through  $V_{CC}$  listed in the *Absolute Maximum Ratings*.

The ground must be capable of sinking current equal to the total current to be sunk by all outputs of the SN74HCS137 plus the maximum supply current, I<sub>CC</sub>, listed in *Electrical Characteristics*, and any transient current required for switching. The logic device can only sink as much current as can be sunk into its ground connection. Be sure not to exceed the maximum total current through GND listed in the *Absolute Maximum Ratings*.

The SN74HCS137 can drive a load with a total capacitance less than or equal to 50 pF while still meeting all of the datasheet specifications. Larger capacitive loads can be applied, however it is not recommended to exceed 50 pF.

The SN74HCS137 can drive a load with total resistance described by  $R_L \ge V_O / I_O$ , with the output voltage and current defined in the *Electrical Characteristics* table with  $V_{OH}$  and  $V_{OL}$ . When outputting in the high state, the

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output voltage in the equation is defined as the difference between the measured output voltage and the supply voltage at the  $V_{CC}$  pin.

Total power consumption can be calculated using the information provided in CMOS Power Consumption and Cpd Calculation.

Thermal increase can be calculated using the information provided in Thermal Characteristics of Standard Linear and Logic (SLL) Packages and Devices.

#### 注意

The maximum junction temperature,  $T_{J(max)}$  listed in the *Absolute Maximum Ratings*, is an additional limitation to prevent damage to the device. Do not violate any values listed in the *Absolute Maximum Ratings*. These limits are provided to prevent damage to the device.

# 9.2.1.2 Input Considerations

Input signals must cross  $V_{t-(min)}$  to be considered a logic LOW, and  $V_{t+(max)}$  to be considered a logic HIGH. Do not exceed the maximum input voltage range found in the *Absolute Maximum Ratings*.

Unused inputs must be terminated to either  $V_{CC}$  or ground. These can be directly terminated if the input is completely unused, or they can be connected with a pull-up or pull-down resistor if the input is to be used sometimes, but not always. A pull-up resistor is used for a default state of HIGH, and a pull-down resistor is used for a default state of LOW. The resistor size is limited by drive current of the controller, leakage current into the SN74HCS137, as specified in the *Electrical Characteristics*, and the desired input transition rate. A 10-k $\Omega$  resistor value is often used due to these factors.

The SN74HCS137 has no input signal transition rate requirements because it has Schmitt-trigger inputs.

Another benefit to having Schmitt-trigger inputs is the ability to reject noise. Noise with a large enough amplitude can still cause issues. To know how much noise is too much, please refer to the  $\Delta V_{T(min)}$  in the *Electrical Characteristics*. This hysteresis value will provide the peak-to-peak limit.

Unlike what happens with standard CMOS inputs, Schmitt-trigger inputs can be held at any valid value without causing huge increases in power consumption. The typical additional current caused by holding an input at a value other than V<sub>CC</sub> or ground is plotted in the *Typical Characteristics*.

Refer to the Feature Description section for additional information regarding the inputs for this device.

#### 9.2.1.3 Output Considerations

The positive supply voltage is used to produce the output HIGH voltage. Drawing current from the output will decrease the output voltage as specified by the  $V_{OH}$  specification in the *Electrical Characteristics*. The ground voltage is used to produce the output LOW voltage. Sinking current into the output will increase the output voltage as specified by the  $V_{OL}$  specification in the *Electrical Characteristics*.

Push-pull outputs that could be in opposite states, even for a very short time period, should never be connected directly together. This can cause excessive current and damage to the device.

Two channels within the same device with the same input signals can be connected in parallel for additional output drive strength.

Unused outputs can be left floating. Do not connect outputs directly to  $V_{\text{CC}}$  or ground.

Refer to Feature Description section for additional information regarding the outputs for this device.

### 9.2.2 Detailed Design Procedure

Add a decoupling capacitor from V<sub>CC</sub> to GND. The capacitor needs to be placed physically close to the
device and electrically close to both the V<sub>CC</sub> and GND pins. An example layout is shown in the Layout
section.



- 2. Ensure the capacitive load at the output is ≤ 50 pF. This is not a hard limit, however it will ensure optimal performance. This can be accomplished by providing short, appropriately sized traces from the SN74HCS137 to the receiving device(s).
- 3. Ensure the resistive load at the output is larger than  $(V_{CC} / I_{O(max)}) \Omega$ . This will ensure that the maximum output current from the *Absolute Maximum Ratings* is not violated. Most CMOS inputs have a resistive load measured in megaohms; much larger than the minimum calculated above.
- 4. Thermal issues are rarely a concern for logic gates, however the power consumption and thermal increase can be calculated using the steps provided in the application report, CMOS Power Consumption and Cpd Calculation.

# 9.2.3 Application Curve

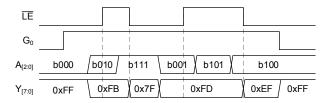


図 9-2. Application timing diagram

English Data Sheet: SCLS831

# 10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each  $V_{CC}$  terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- $\mu$ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1- $\mu$ F and 1- $\mu$ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results, as shown in given example layout image.

### 11 Layout

#### 11.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or V<sub>CC</sub>, whichever makes more sense for the logic function or is more convenient.

#### 11.2 Layout Example

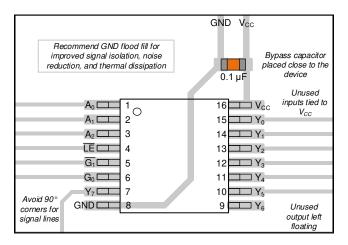


図 11-1. Example layout for the SN74HCS137 in the PW package.



# 12 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

# **12.1 Documentation Support**

#### 12.1.1 Related Documentation

For related documentation see the following:

- Texas Instruments, HCMOS Design Considerations application report (SCLA007)
- Texas Instruments, CMOS Power Consumption and Cpd Calculation application report (SDYA009)
- Texas Instruments, Designing With Logic application report

#### 12.2 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、www.tij.co.jp のデバイス製品フォルダを開いてください。「更新の通知を受け取る」をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取れます。変更の詳細については、修正されたドキュメントに含まれている改訂履歴をご覧ください。

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#### 12.6 用語集

テキサス・インスツルメンツ用語集 この用語集には、用語や略語の一覧および定義が記載されています。

English Data Sheet: SCLS831



# 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: SN74HCS137

www.ti.com 9-Nov-2025

#### PACKAGING INFORMATION

| Orderable part number | Status | Material type | Package   Pins  | Package qty   Carrier | RoHS | Lead finish/  | MSL rating/        | Op temp (°C) | Part marking |
|-----------------------|--------|---------------|-----------------|-----------------------|------|---------------|--------------------|--------------|--------------|
|                       | (1)    | (2)           |                 |                       | (3)  | Ball material | Peak reflow        |              | (6)          |
|                       |        |               |                 |                       |      | (4)           | (5)                |              |              |
| SN74HCS137DR          | Active | Production    | SOIC (D)   16   | 2500   LARGE T&R      | Yes  | NIPDAU   SN   | Level-1-260C-UNLIM | -40 to 125   | HCS137       |
| SN74HCS137DR.A        | Active | Production    | SOIC (D)   16   | 2500   LARGE T&R      | Yes  | NIPDAU        | Level-1-260C-UNLIM | -40 to 125   | HCS137       |
| SN74HCS137PWR         | Active | Production    | TSSOP (PW)   16 | 2000   LARGE T&R      | Yes  | NIPDAU   SN   | Level-1-260C-UNLIM | -40 to 125   | HCS137       |
| SN74HCS137PWR.A       | Active | Production    | TSSOP (PW)   16 | 2000   LARGE T&R      | Yes  | NIPDAU        | Level-1-260C-UNLIM | -40 to 125   | HCS137       |

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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#### OTHER QUALIFIED VERSIONS OF SN74HCS137:

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# PACKAGE OPTION ADDENDUM

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• Automotive : SN74HCS137-Q1

NOTE: Qualified Version Definitions:

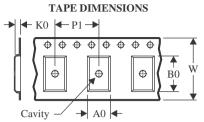
• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

# **PACKAGE MATERIALS INFORMATION**

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# TAPE AND REEL INFORMATION





| A0 | Dimension designed to accommodate the component width     |
|----|---|
| В0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

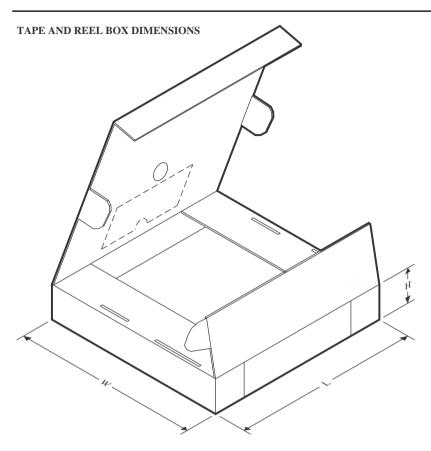
#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

| Device        | Package<br>Type | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|---------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| SN74HCS137DR  | SOIC            | D                  | 16 | 2500 | 330.0                    | 16.4                     | 6.5        | 10.3       | 2.1        | 8.0        | 16.0      | Q1               |
| SN74HCS137PWR | TSSOP           | PW                 | 16 | 2000 | 330.0                    | 12.4                     | 6.9        | 5.6        | 1.6        | 8.0        | 12.0      | Q1               |

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# \*All dimensions are nominal

| Device        | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|---------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN74HCS137DR  | SOIC         | D               | 16   | 2500 | 353.0       | 353.0      | 32.0        |
| SN74HCS137PWR | TSSOP        | PW              | 16   | 2000 | 356.0       | 356.0      | 35.0        |



SMALL OUTLINE PACKAGE



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



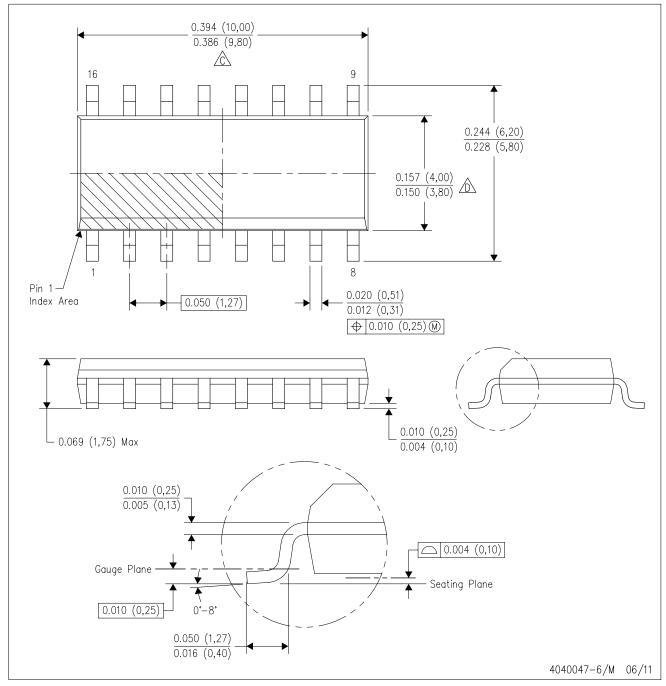
NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# D (R-PDS0-G16)

# PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



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